Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	
10/724,561	BHATTACHAR	JEE ET AL.
Examiner	Art Unit	
Patricia T. Nguyen	2817	

SEARCHED						
Class	Subclass	Date	Examiner			
330	254	4/8/2005	PN			
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330	254	4/8/2005	PN
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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